

<b>Notice of References Cited</b>	Application/Control No. 09/901,913	Applicant(s)/Patent Under Reexamination MATSUSHITA ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0038425 /	11-2001	Lee	349/61
	B	US-5,877,829 /	03-1999	Okamoto et al	349/74
	C	US-6,084,714 /	07-2000	Ushiyama et al	359/627
	D	US-2002/0057562 /	05-2002	Sasako et al	362/31
	E	US-6,091,547 /	07-2000	Gardiner et al	359/625
	F	US-5,808,708 /	09-1998	Oyama et al	349/65
	G	US-5,914,760 /	06-1999	Dakiu	349/65
	H	US-6,504,589 /	01-2003	Kashima et al	349/96
	I	US-6,074,070 /	06-2000	Sasako	362/34
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 9-147615 /	06-1997	Japan	Yamane	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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